Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/826,127	FURUKAWA ET AL.	
Examiner	Art Unit	
Brian E. Miller	2627	

CEARCUED					
SEARCHED					
Class	Subclass	Date	Examiner		
360	324.1				
360	324.11				
360	324.12				
360	324.2	3/19/2006	ВЕМ		
updated	as above	11/24/2006	BEM		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u></u>			

DATE	EXMR
3/19/2006	ВЕМ